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Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/669,469	OKUGAWA ET AL.		
Examiner	Art Unit		
Matthew D. Matzek	1771		

SEARCHED			
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
IDS	4/1/2005	мм
	16/ry/enst	11.0
Inventor Name Search Y ASSIGNEE	4/1/2005 Myyfurs	MM
EAST up dufed	4/1/2005	MM Pr pr